

**N- AND P-Channel Enhancement Mode MOSFET**

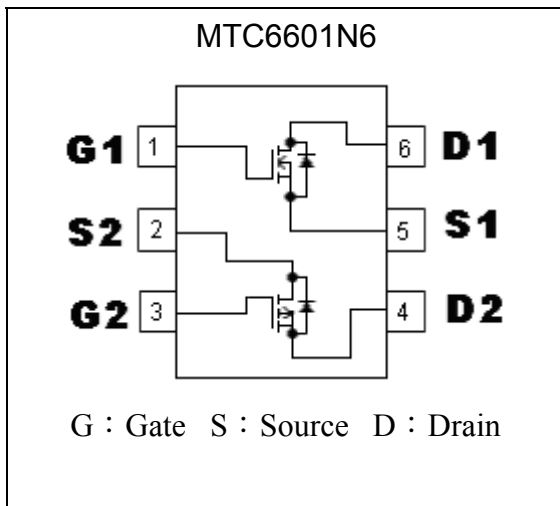
# MTC6601N6

	N-CH	P-CH
$BV_{DSS}$	30V	-30V
$I_D$	3.7A( $V_{GS}=10V$ )	-2.7A( $V_{GS}=-10V$ )
$R_{DS(on)}$ (TYP.)	37.7m $\Omega$ ( $V_{GS}=10V$ )	91.3m $\Omega$ ( $V_{GS}=-10V$ )
	42.7m $\Omega$ ( $V_{GS}=4.5V$ )	104m $\Omega$ ( $V_{GS}=-4.5V$ )
	62.6m $\Omega$ ( $V_{GS}=2.5V$ )	132m $\Omega$ ( $V_{GS}=-2.5V$ )

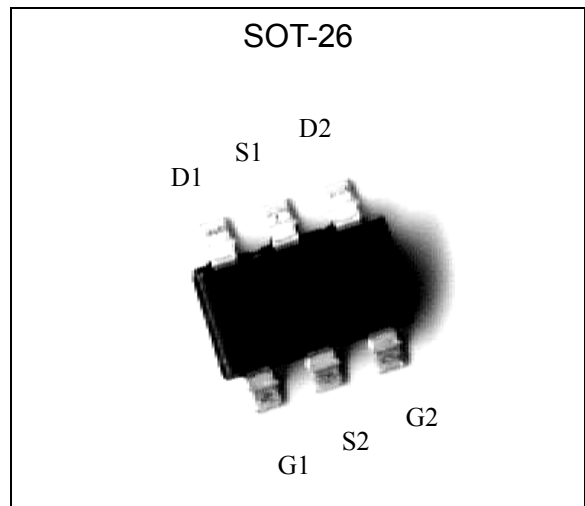
**Features**

- Simple drive requirement
- Low gate charge
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package

**Equivalent Circuit**

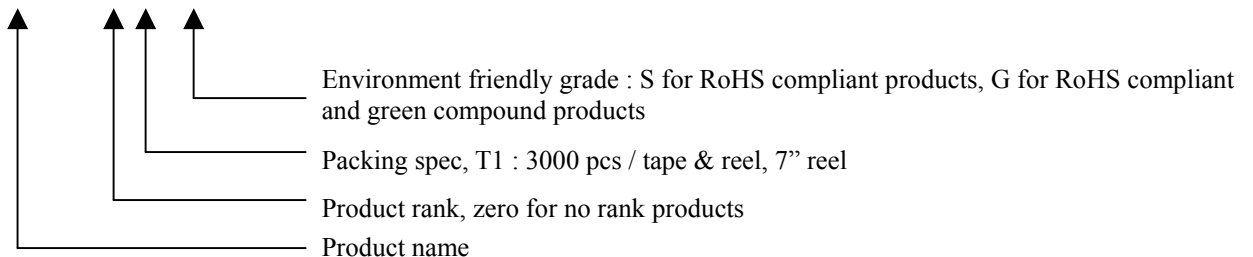


**Outline**



**Ordering Information**

Device	Package	Shipping
MTC6601N6-0-T1-G	SOT-26 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





**Absolute Maximum Ratings (Ta=25°C)**

Parameter		Symbol	Limits		Unit
			N-channel	P-channel	
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	30	-30	V
Gate-Source Voltage		V <sub>GS</sub>	±12	±12	
Continuous Drain Current (Note 1)	T <sub>A</sub> =25°C, V <sub>GS</sub> =10V(N-CH), V <sub>GS</sub> =-10V(P-CH)	I <sub>D</sub>	3.7	-2.7	A
	T <sub>A</sub> =70°C, V <sub>GS</sub> =10V(N-CH), V <sub>GS</sub> =-10V(P-CH)	I <sub>D</sub>	3.0	-2.2	
Pulsed Drain Current (Note 2)		I <sub>DM</sub>	22	-16	
Total Power Dissipation (Note 1)		P <sub>D</sub>	1.14		W
Operating Junction and Storage Temperature		T <sub>j</sub> , T <sub>stg</sub>	-55~+150		°C
Thermal Resistance, Junction-to-Ambient (Note 1)		R <sub>θJA</sub>	110		°C/W
Thermal Resistance, Junction-to-Case		R <sub>θJC</sub>	60		

Note : 1.Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, t≤5 sec; 180°C/W when mounted on minimum copper pad.  
 2.Pulse width limited by maximum junction temperature.

**N-Channel Electrical Characteristics (Tj=25°C, unless otherwise specified)**

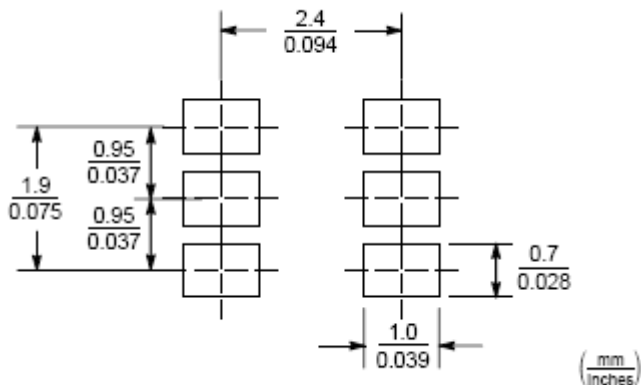
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	0.5	-	1.5		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V
	-	-	25		V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>j</sub> =70°C
*R <sub>DSON</sub>	-	37.7	55	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =3.4A
	-	42.7	65		V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A
	-	62.6	90		V <sub>GS</sub> =2.5V, I <sub>D</sub> =2A
*G <sub>FS</sub>	-	4.3	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =3A
<b>Dynamic</b>					
C <sub>iss</sub>	-	315	-	pF	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	46	-		
C <sub>rss</sub>	-	33	-		
*t <sub>d(ON)</sub>	-	3.6	-	ns	V <sub>DS</sub> =15V, I <sub>D</sub> =3.4A, V <sub>GS</sub> =10V, R <sub>G</sub> =6Ω
*t <sub>r</sub>	-	16.6	-		
*t <sub>d(OFF)</sub>	-	24.4	-		
*t <sub>f</sub>	-	4.2	-		
*Q <sub>g</sub>	-	9.4	-	nC	V <sub>DS</sub> =15V, I <sub>D</sub> =3.4A, V <sub>GS</sub> =10V
*Q <sub>gs</sub>	-	1.6	-		
*Q <sub>gd</sub>	-	0.8	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	0.8	1	V	V <sub>GS</sub> =0V, I <sub>S</sub> =1A
*t <sub>rr</sub>	-	7.7	-	ns	I <sub>F</sub> =1A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	3.3	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

**P-Channel Electrical Characteristics** (T<sub>j</sub>=25°C, unless otherwise specified)

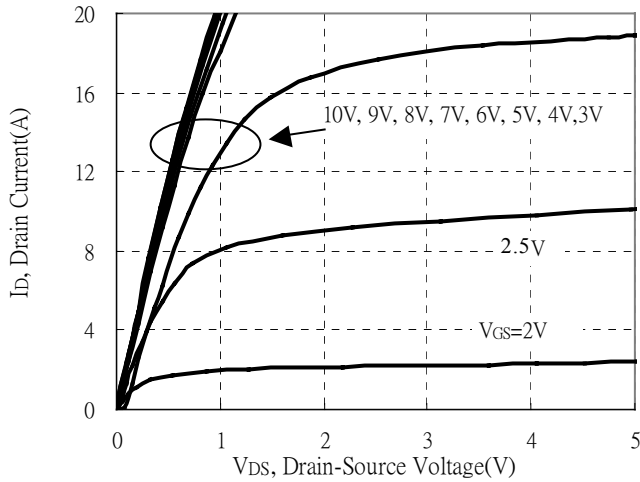
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
B <sub>V</sub> D <sub>SS</sub>	-30	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA
V <sub>GS(th)</sub>	-0.5	-	-1.2		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	-1	μA	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V
	-	-	-10		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0, T <sub>j</sub> =70°C
*R <sub>DS(ON)</sub>	-	91.3	110	mΩ	V <sub>GS</sub> =-10V, I <sub>D</sub> =-2.3A
	-	104	145		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A
	-	132	190		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-1A
*G <sub>FS</sub>	-	4	-	S	V <sub>DS</sub> =-5V, I <sub>D</sub> =-2.3A
<b>Dynamic</b>					
C <sub>iss</sub>	-	480	-	pF	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	63	-		
C <sub>rss</sub>	-	33	-		
*t <sub>d(ON)</sub>	-	4.4	-	ns	V <sub>DD</sub> =-15V, I <sub>D</sub> =-2.3A, V <sub>GS</sub> =-4.5V, R <sub>G</sub> =6Ω
*t <sub>r</sub>	-	17.2	-		
*t <sub>d(OFF)</sub>	-	43	-		
*t <sub>f</sub>	-	6.8	-		
*Q <sub>g</sub>	-	11.4	-	nC	V <sub>DS</sub> =-15V, I <sub>D</sub> =-2.3A, V <sub>GS</sub> =-10V
*Q <sub>gs</sub>	-	1.3	-		
*Q <sub>gd</sub>	-	0.7	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	-0.83	-1	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A
*t <sub>rr</sub>	-	7	-	ns	I <sub>F</sub> =-1A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	2.9	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

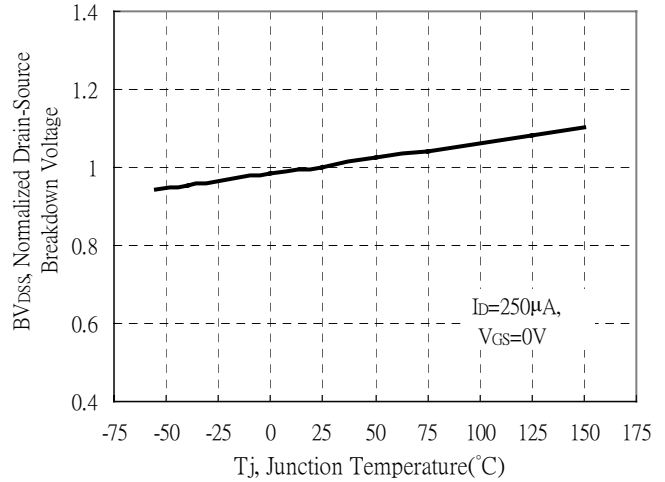
**Recommended Soldering Footprint**


## N-channel Typical Characteristics

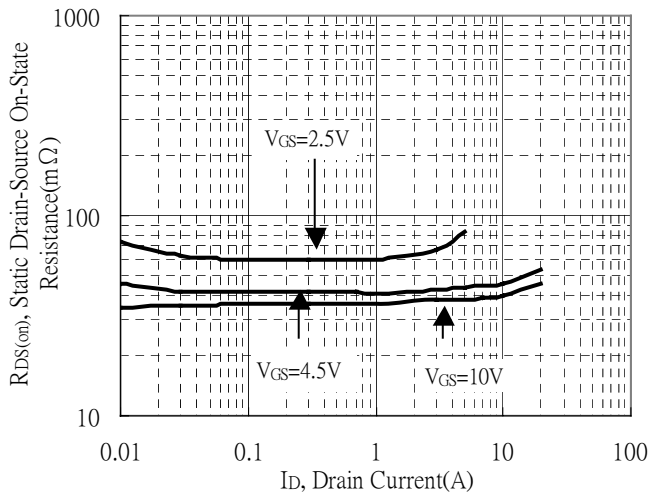
Typical Output Characteristics



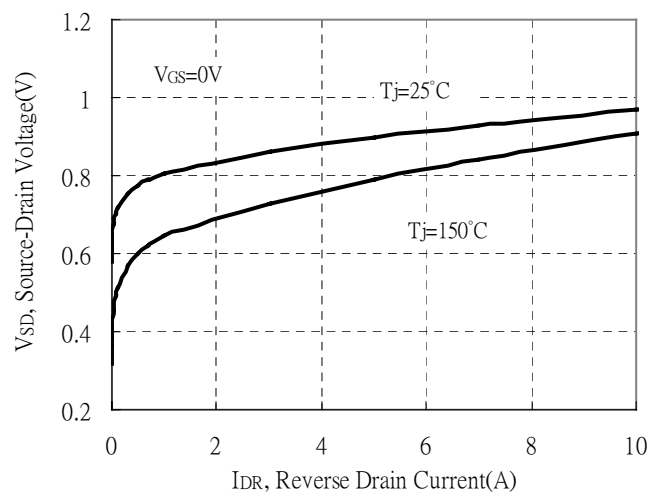
Brekdown Voltage vs Ambient Temperature



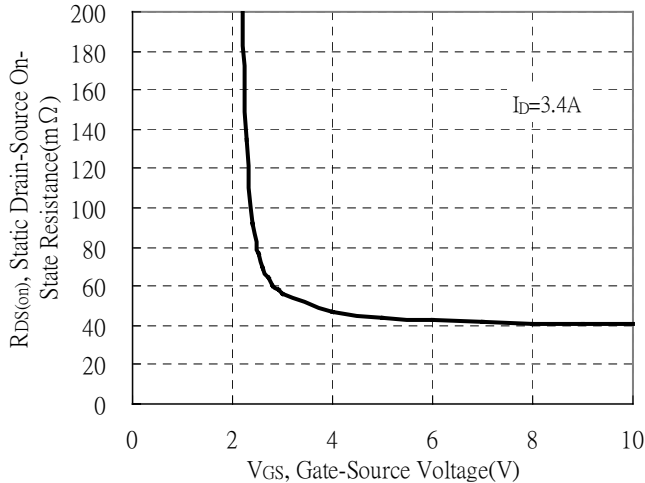
Static Drain-Source On-State resistance vs Drain Current



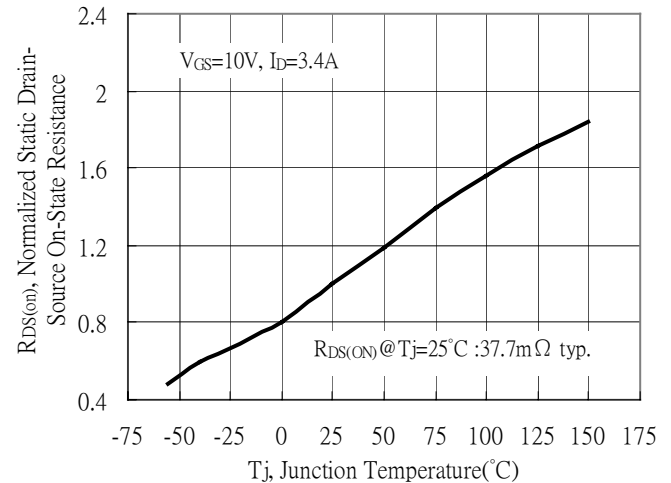
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

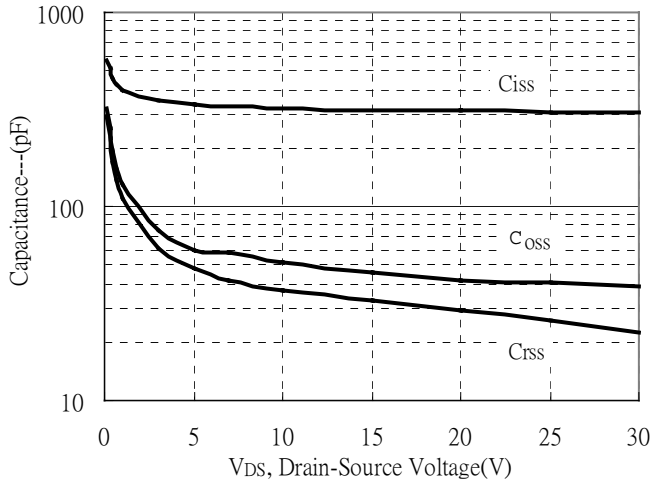


Drain-Source On-State Resistance vs Junction Temperature

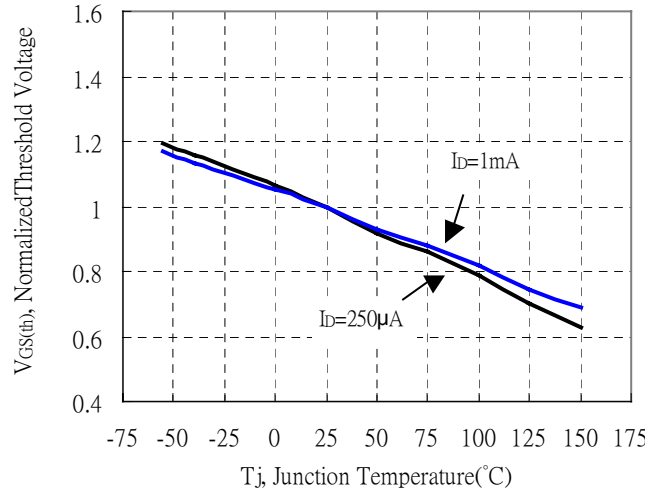


**N-channel Typical Characteristics(Cont.)**

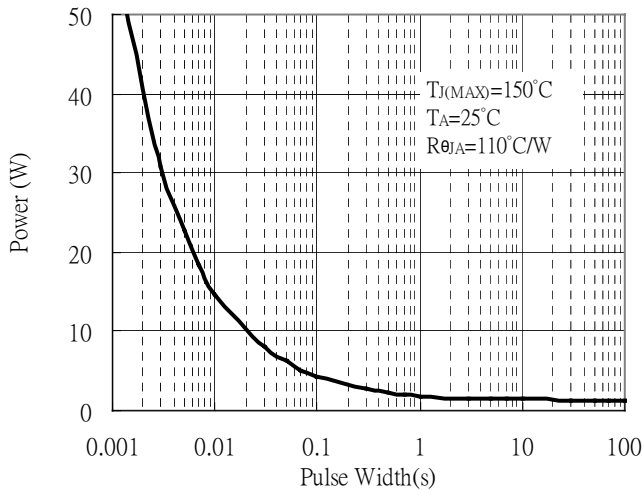
Capacitance vs Drain-to-Source Voltage



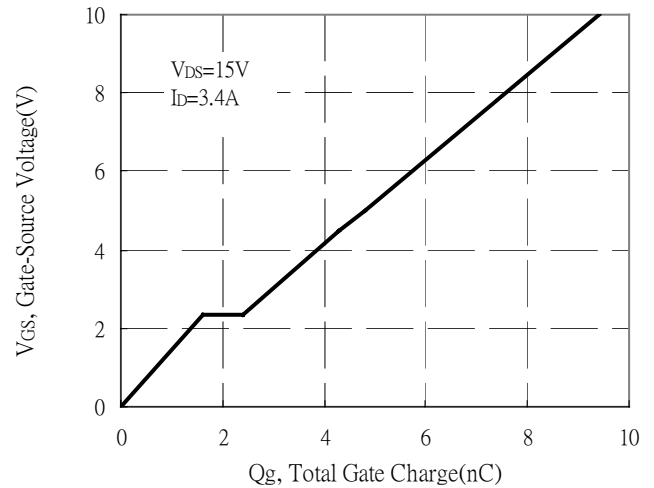
Threshold Voltage vs Junction Temperature



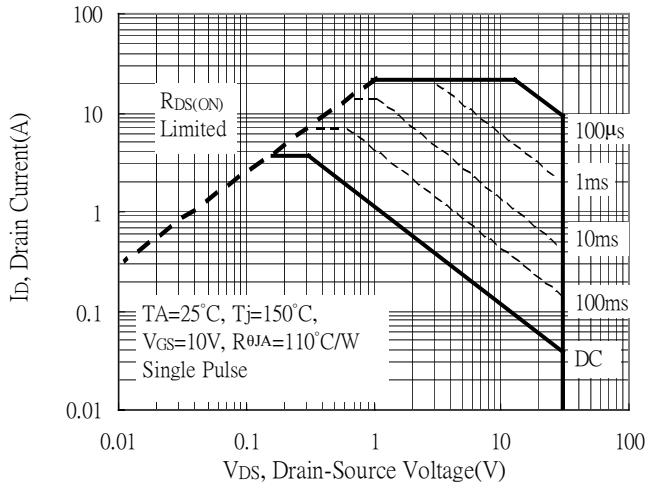
Single Pulse Power Rating, Junction to Ambient



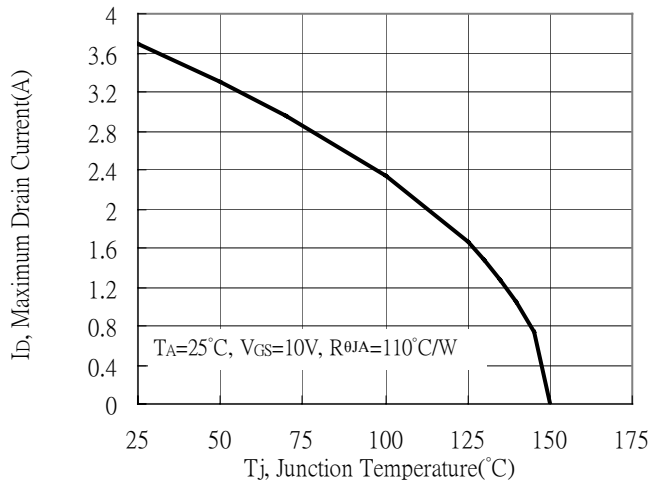
Gate Charge Characteristics



Maximum Safe Operating Area

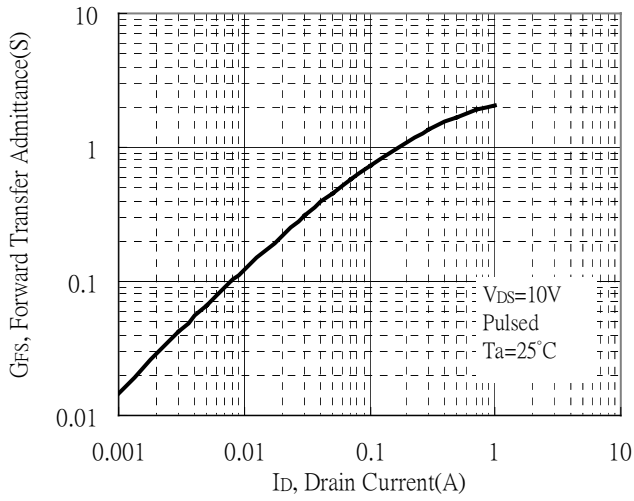


Maximum Drain Current vs Junction Temperature

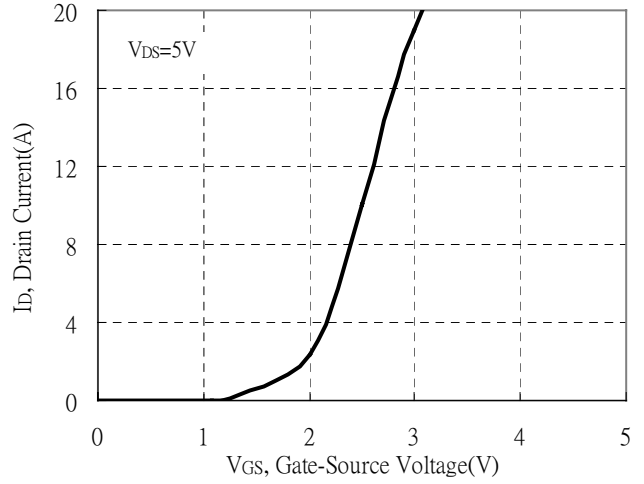


**N-channel Typical Characteristics(Cont.)**

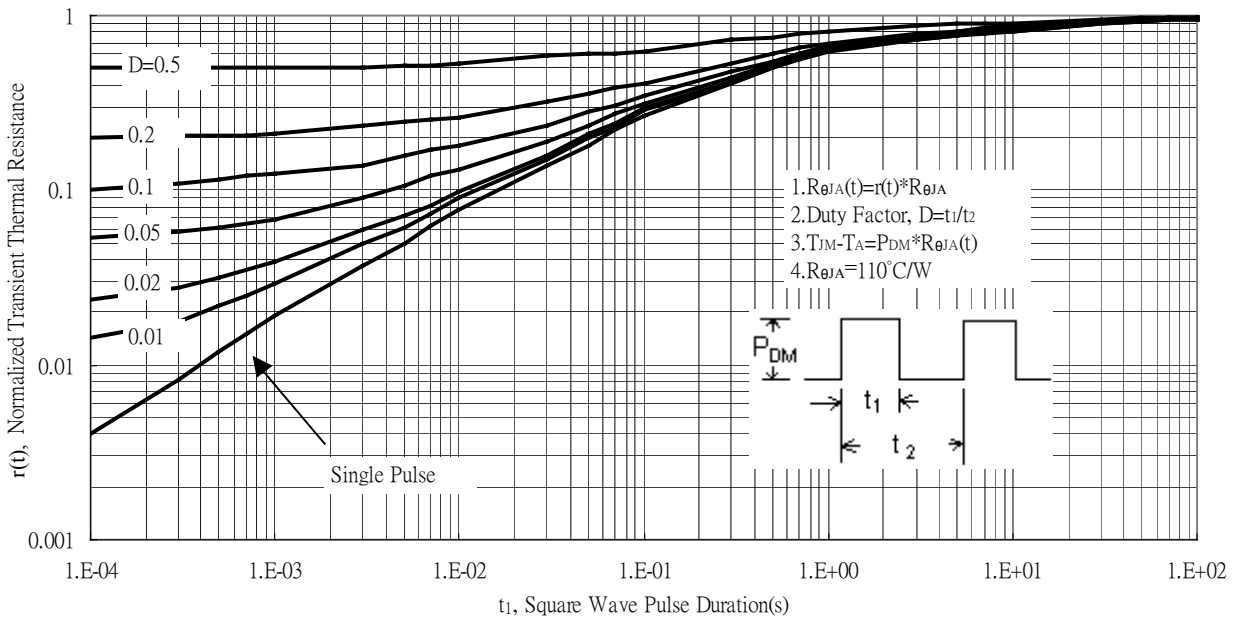
Forward Transfer Admittance vs Drain Current



Typical Transfer Characteristics

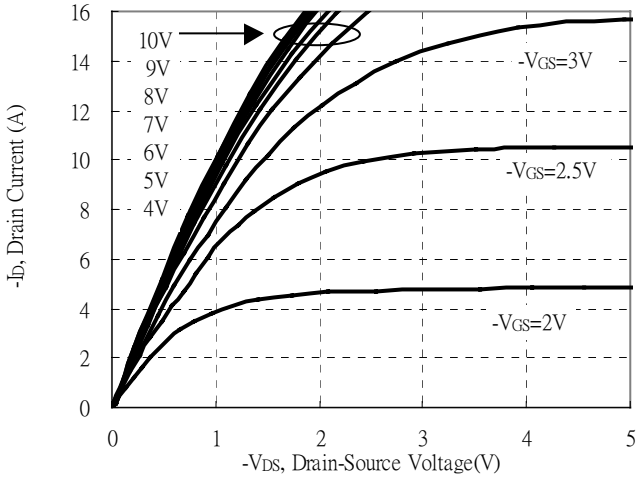


Transient Thermal Response Curves

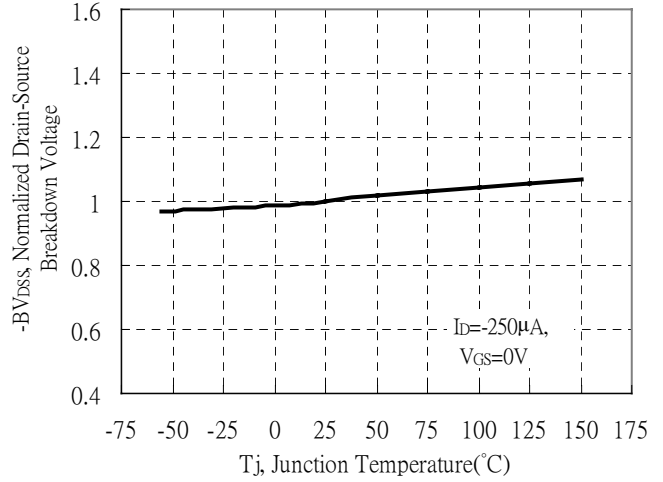


## P-channel Typical Characteristics

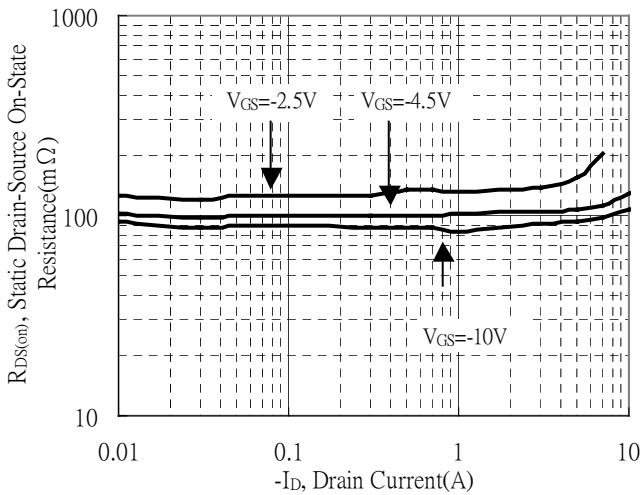
Typical Output Characteristics



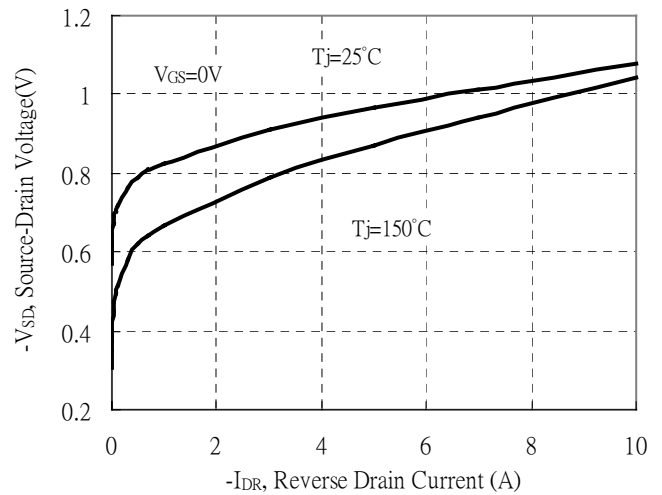
Breakdown Voltage vs Ambient Temperature



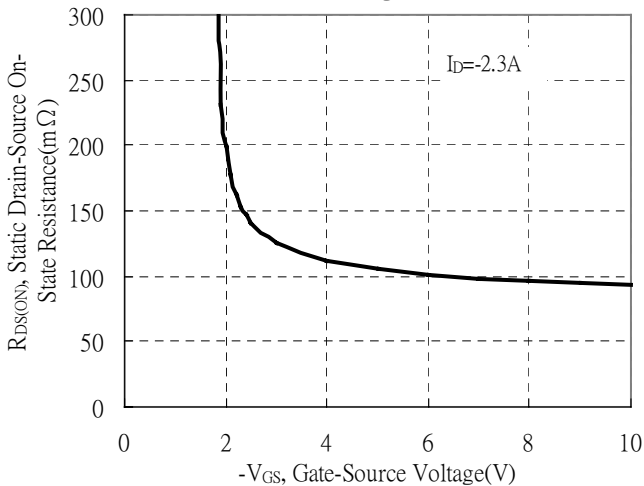
Static Drain-Source On-State resistance vs Drain Current



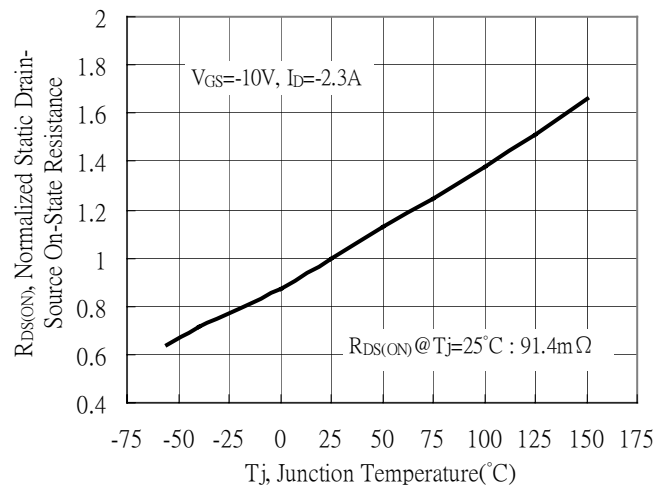
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

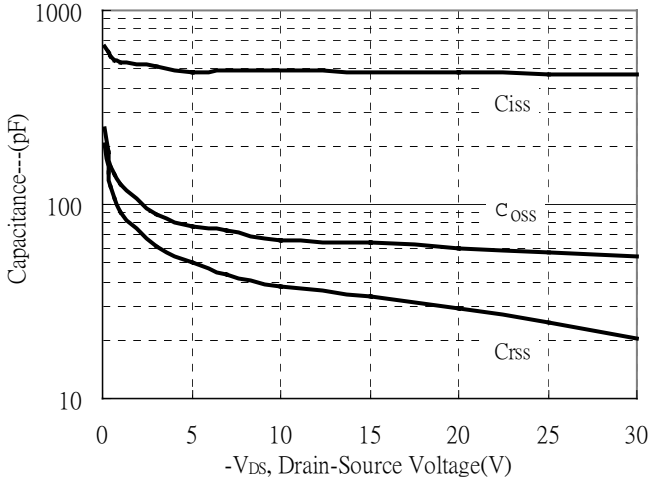


Drain-Source On-State Resistance vs Junction Temperature

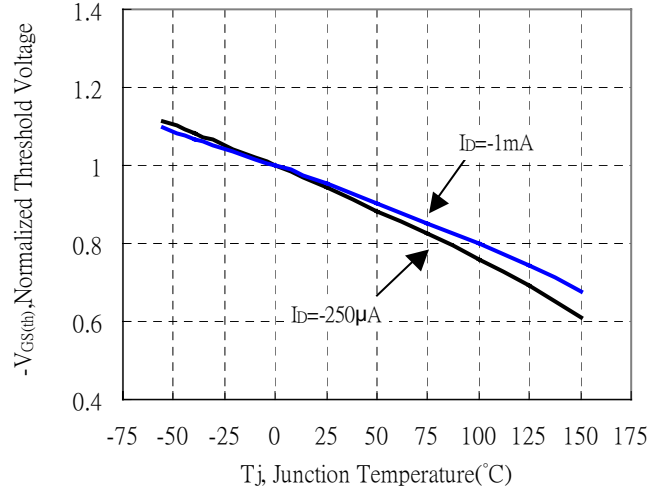


**P-channel Typical Characteristics(Cont.)**

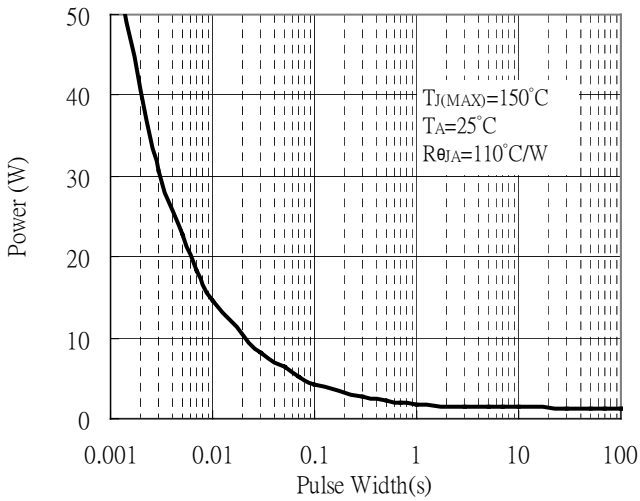
Capacitance vs Drain-to-Source Voltage



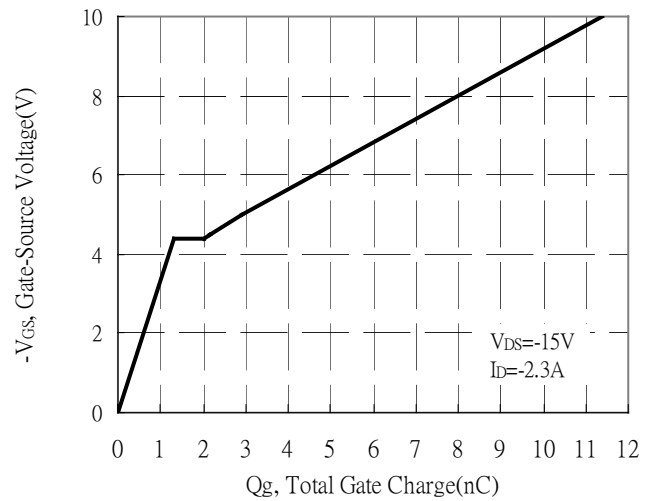
Threshold Voltage vs Junction Temperature



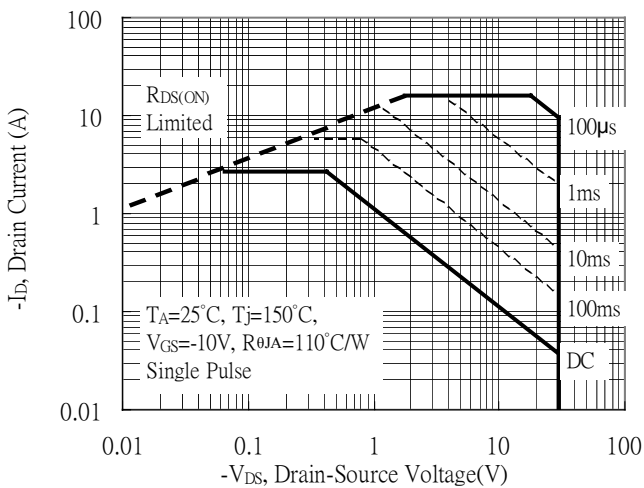
Single Pulse Power Rating, Junction to Ambient



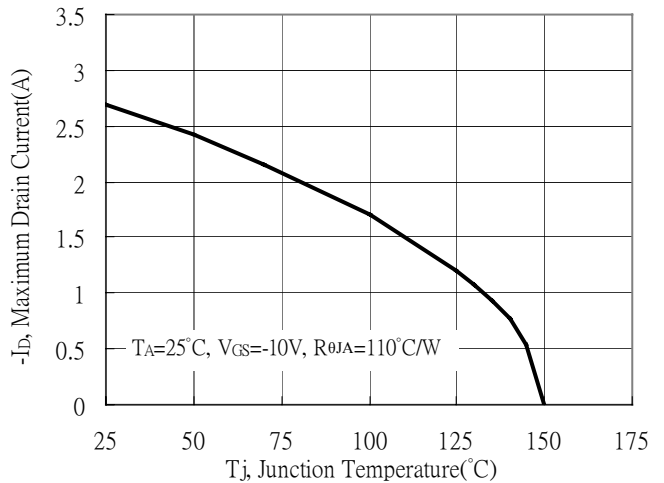
Gate Charge Characteristics



Maximum Safe Operating Area



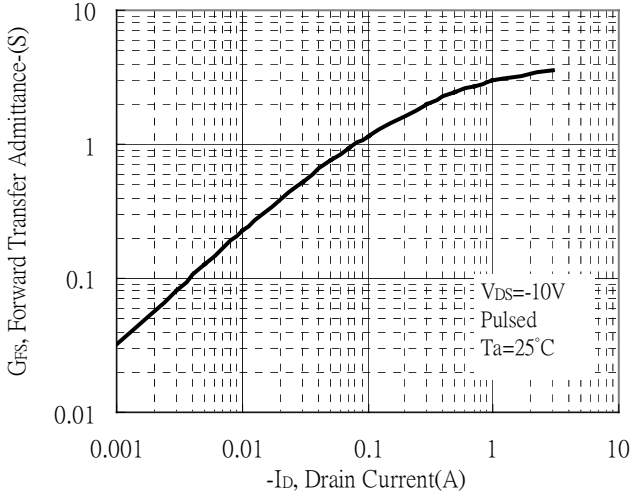
Maximum Drain Current vs Junction Temperature



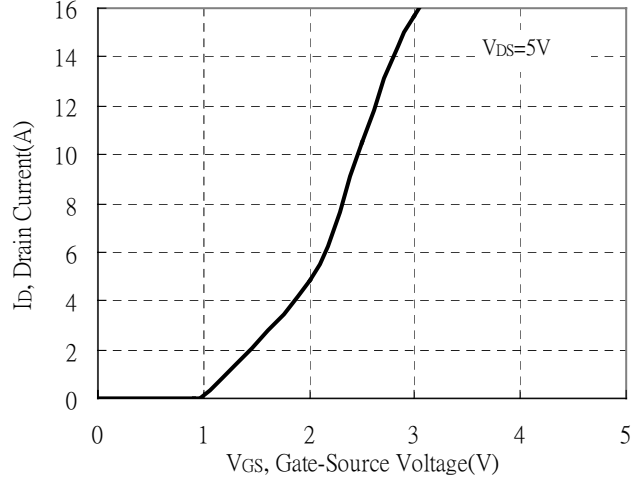


**P-channel Typical Characteristics(Cont.)**

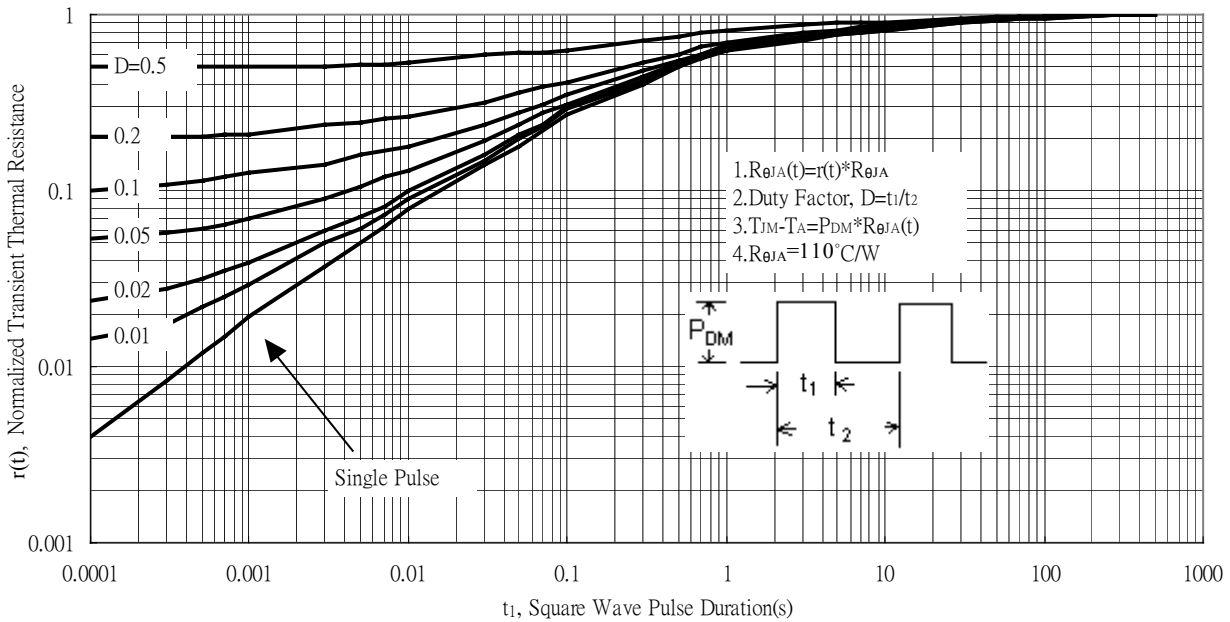
Forward Transfer Admittance vs Drain Current



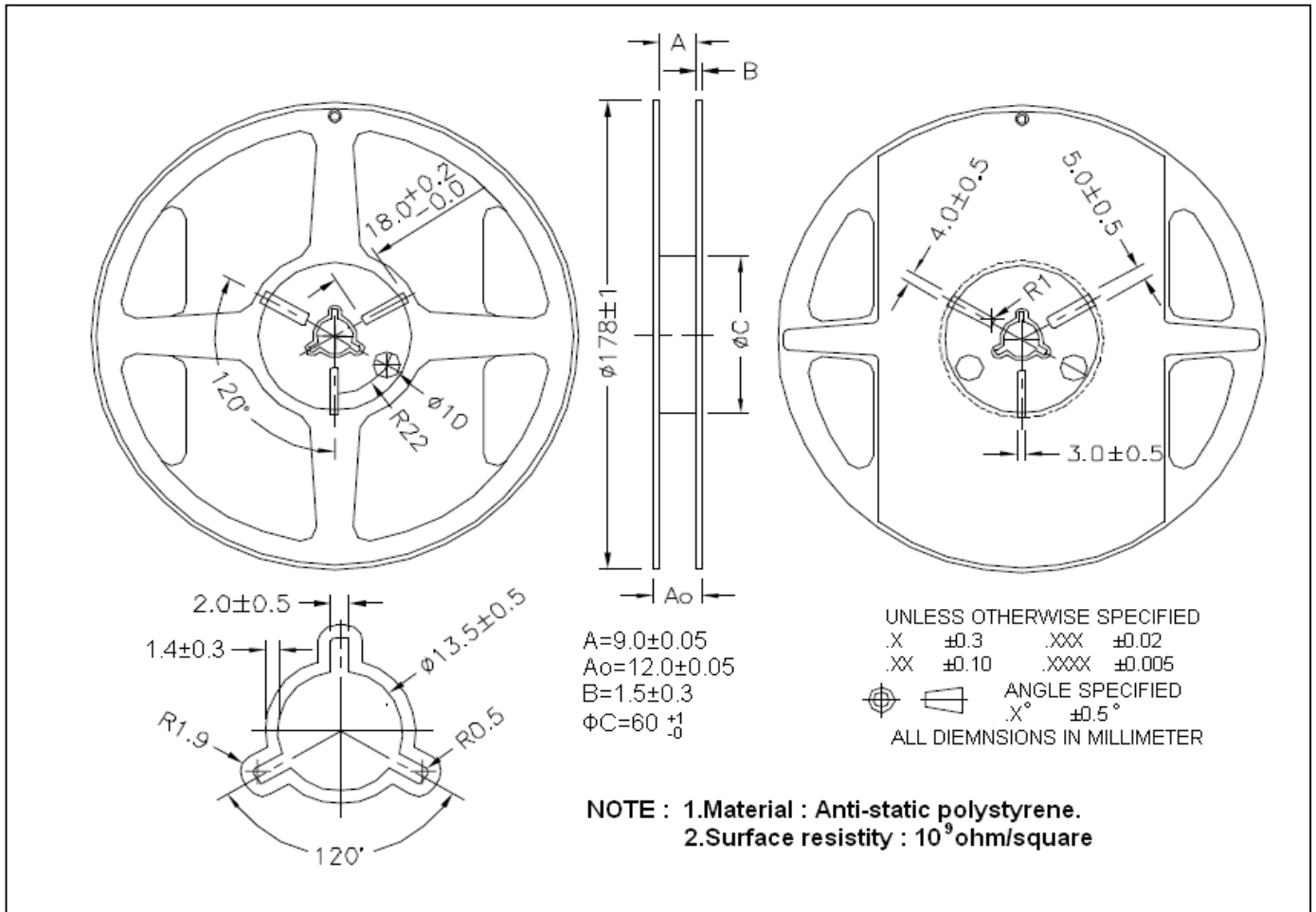
Typical Transfer Characteristics



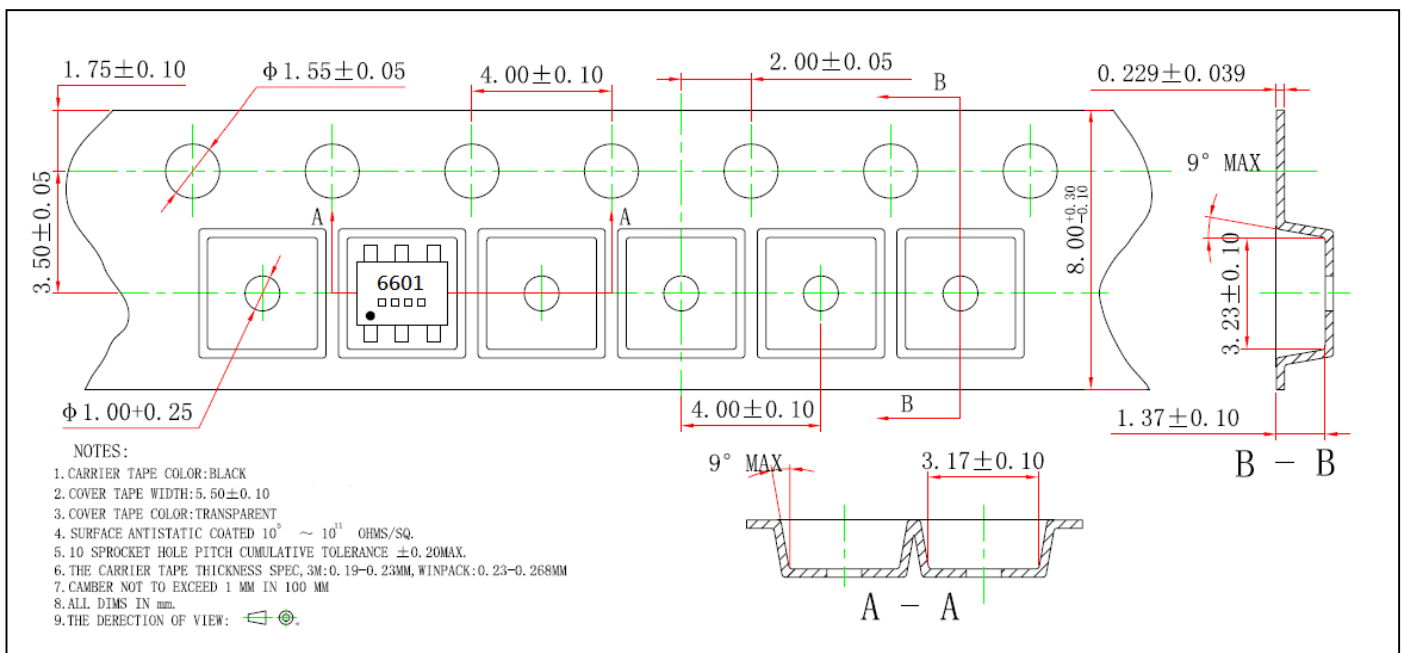
Transient Thermal Response Curves



**Reel Dimension**



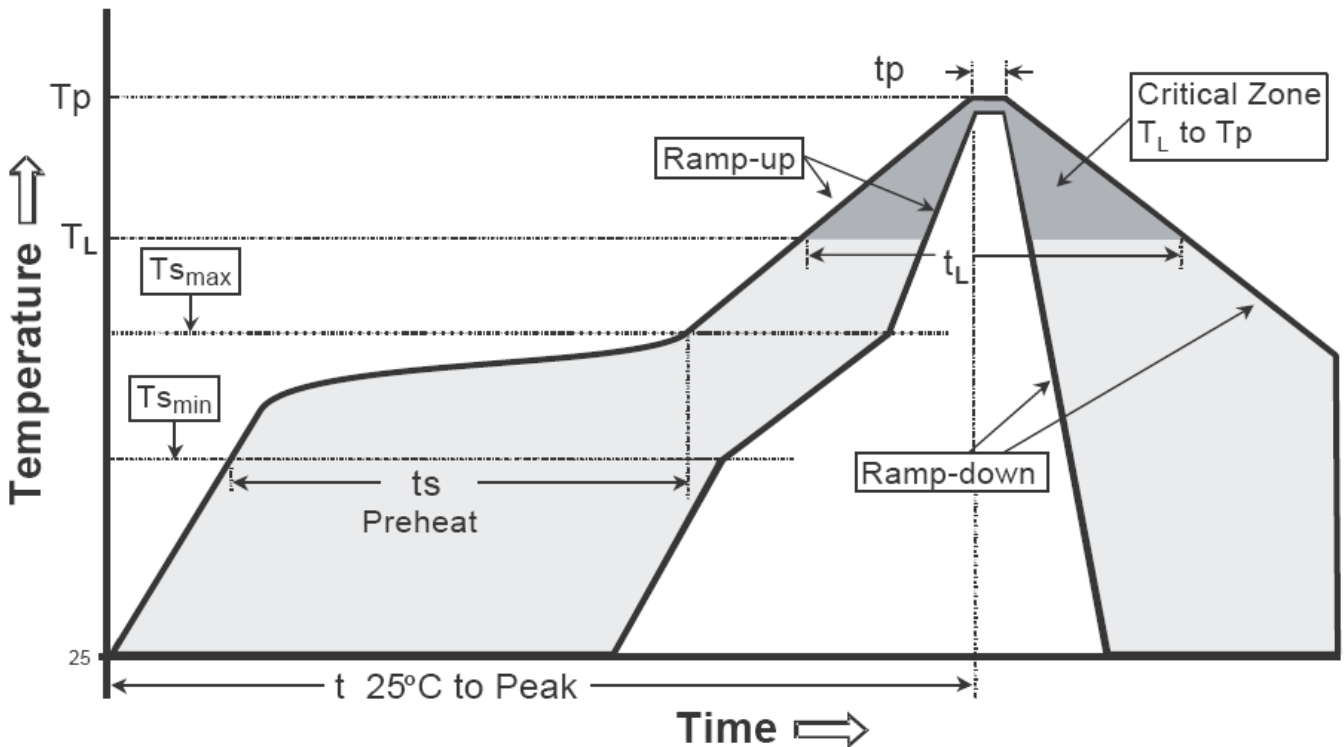
**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

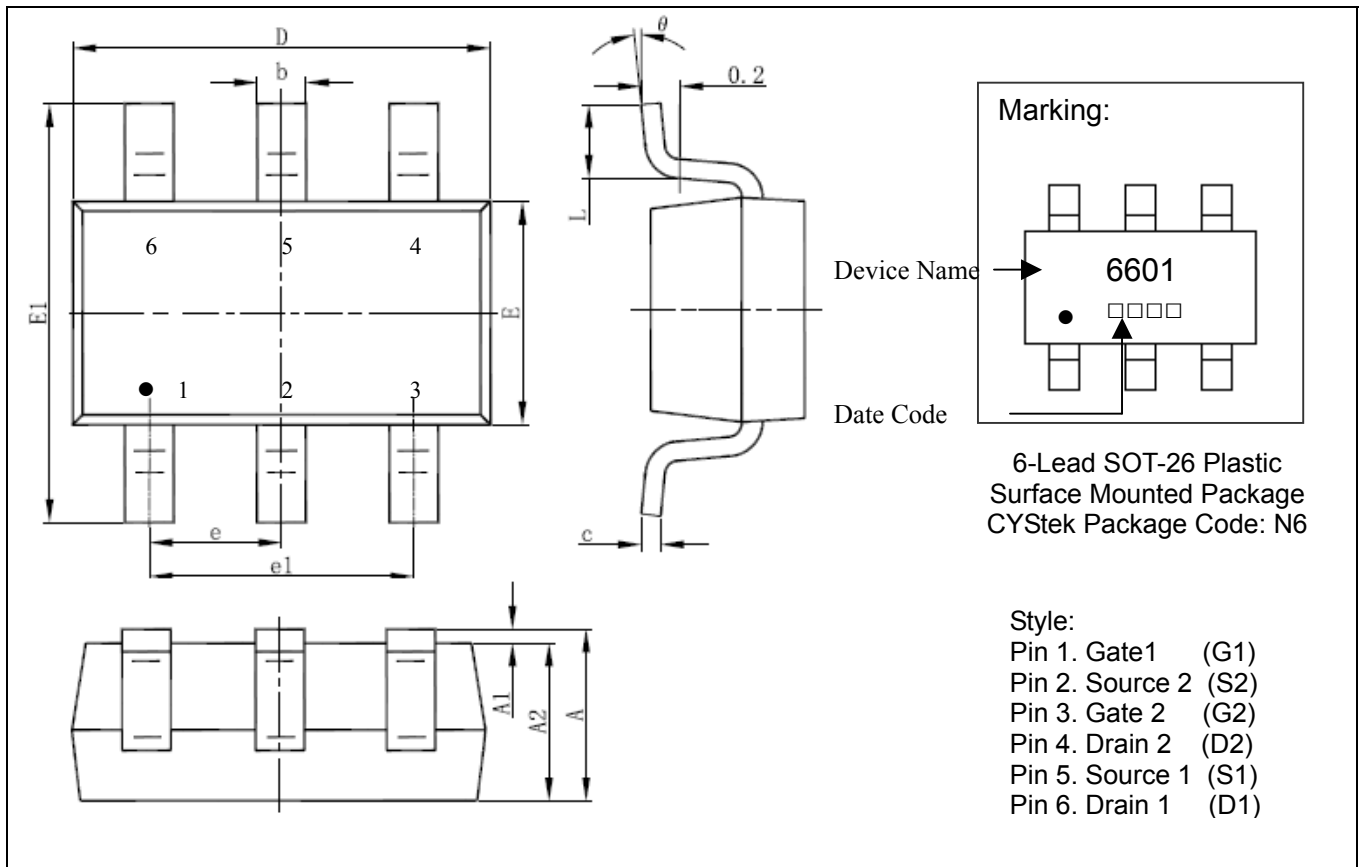
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note :1. All temperatures refer to topside of the package, measured on the package body surface.  
 2.For devices mounted on FR-4 PCB of 1.6mm or equivalent grade PCB. If other grade PCB is used, care should be taken to match the coefficients of thermal expansion between components and PCB. If they are not matched well, the solder joints may crack or the bodies of the parts may crack or shatter as the assembly cools.

**SOT-26 Dimension**



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049	E	1.500	1.700	0.059	0.067
A1	0.000	0.100	0.000	0.004	E1	2.650	2.950	0.104	0.116
A2	1.050	1.150	0.041	0.045	e	0.950 (BSC)		0.037 (BSC)	
b	0.300	0.500	0.012	0.020	e1	1.800	2.000	0.071	0.079
c	0.100	0.200	0.004	0.008	L	0.300	0.600	0.012	0.024
D	2.820	3.020	0.111	0.119	θ	0°	8°	0°	8°

**Notes :** 1. Controlling dimension : millimeters.  
 2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material :**

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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